Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination OVERSTREET, FRANK R. Examiner | Art Unit | Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0004671	01-2004	Takahashi, Kimihide	348/375
*	В	US-2002/0186317	12-2002	Kayanuma, Yasunobu	348/373
*	С	US-2,670,228	02-1954	PAGLIUSO ROBERT J	403/137
*	D	US-4,081,814	03-1978	Bulland, Julian A.	396/422
*	E	US-7,290,740	11-2007	Joy et al.	248/187.1
*	F	US-7,128,297	10-2006	Lee, Eun-kyung	248/187.1
*	G	US-6,352,228	03-2002	Buerklin, Werner	248/181.1
*	Н	US-5,505,415	04-1996	Brett, Kenneth S.	248/168
*	1	US-916,286	03-1909	Name not available EWnS	248/181.1
*	J	US-1,280,013	09-1918	Name not available Goddard	248/181.1
*	К	US-2,650,788	09-1953	HULSTEIN NEAL S	248/231.71
*	L	US-2,670,228	02-1954	PAGLIUSO ROBERT J	403/137
*	М	US-5,072,907	12-1991	Vogt, Philippe	248/181.1

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP 2004235964 A	08-2004	Japan	IGARI, KAZUO	
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*	,	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	×	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

